Thermal Stability Study of Eu²⁺-doped BaAl₂Si₂O₈ Phosphor using Polymorphism for Plasma Display Panel applications

Won Bin Im^a, Yong-Il Kim^b, Duk Young Jeon^a, z

a) Dept. of Materials Sci. and Eng., Korea Advanced Institute of Sci. & Tech., 373-1, Guseong-dong, Yuseong-gu, Daejeon, 305-701, Republic of Korea

b) Korea Research Institute of Standards and Science, P.O. Box 102, Yuseong, Daejeon , 305-600, Republic of Korea

TEL: +82-42-869-3337, FAX: +82-42-869-3310

^ze-mail: dvi@kaist.ac.kr

Abstract

We have evaluated thermal stability of a $BaAl_2Si_2O_8:Eu^{2+}$ $(BAS:Eu^{2+}),$ which have polymorph property such as hexagonal, monoclinic structure depending upon firing temperature. When both polymorph BAS:Eu² for 30 min, the were baked in air at 500 photoluminescence (PL) intensity of monoclinic-BAS:Eu²⁺ was maintained of the initial intensity. However, the PL intensity of hexagonal-BAS:Eu²⁺ decreased significantly, corresponding to about 34 %. From analyses of Rietveld refinement, the difference of thermal stability of both BAS:Eu²⁺ can be ascribed to both crystal structure of host materials and the average interatomic distances between Eu²⁺ ion and oxygen their crystal structure which plays a key role of shield for Eu²⁺ ions against oxidation atmosphere.

1. Introduction

Recently, plasma display panels (PDPs) have been widely used as large flat panel display (FPD) devices since they have a wide view angle and good image quality among the various FPD devices. However, there are some issues to be related to the performance of phosphors in PDPs manufacturing process. For manufacturing process of panels, all phosphors have to be heat-treated up to 500 for binder burn-out.

Unfortunately, the baking process is unavoidable to seal panels, and is also critical for good adhesion between phosphor and substrate. The blue phosphor, $BaMgAl_{10}O_{17}:Eu^{2+}$ (BAM), has been widely studied because it is significantly less stable than the red and green phosphor components during panel manufacturing process. It has been reported that the thermal degradation of the BAM is probably related with change of either valance of Eu^{2+} to Eu^{3+} or its crystal structure (B-alumina) which has an open layer in the crystal [1-3].

As mentioned above, thermal stability of phosphors during the burn-out of binder after applying phosphor paste in manufacturing of PDPs has been the most important factor demanded by color emitting phosphors. Recently, it is reported CaMgSi₂O₆:Eu²⁺ (CMS:Eu²⁺) which is expected to be a promising material as a new blue PDP phosphor shows no degradation under baking process and plasma discharge environment [4, 5]. Although its thermal stability reported, we do not know which structures have a thermal stability during the baking process. In particular, to determine stable crystal structure for Eu²⁺ ions is very important if we would deign blue phosphor for PDP application or demanded thermal stability. However detailed information on its property is insufficient compared with degradation mechanism of BAM in the baking process. In addition, it is difficult to compare BAM with CMS:Eu²⁺ in terms of thermal stability during the baking process since each phosphor has different chemical composition. Therefore, to investigate thermal stability as a function of crystal structure for

the baking process, we have selected BaA½Si₂O₈:Eu²⁺ (BAS:Eu²⁺) phosphor, which have a polymorph property such as monoclinic, hexagonal structure depending upon firing temperatures. Due to use of polymorph property of BAS:Eu²⁺, we can successively exclude contributions of differences in chemical compositions for thermal stability evaluation.

In this study, we have synthesized of single phase monoclinic and hexagonal BAS:Eu²⁺ phosphor and evaluated their thermal stability depending upon its crystal structures. Furthermore, this letter suggests a criterion of selection of host lattices for a PDP blue-emitting phosphor from a point of view of thermal stability during the baking process.

2. Experimental

Powder samples of polymorph BAS:Eu²⁺ were prepared by conventional solid-state reaction method. To synthesize phosphors, BaCO₃, Al₂O₃, SiO₂ and EuF₃ were used as raw materials. Small quantities of NH₄F were added as a flux. The raw materials of BAS:Eu²⁺ were mixed in a ball mill mixer for 12 hours and firing temperatures between 1300 and were employed in a reducing atmosphere of 1400 mixture between H_2 (5%) and N_2 (95%) for 3 hours, respectively. To investigate the effect of baking process, the samples were baked at 500 30 min. PL spectra were obtained at room temperature by scanning wavelength region from 300 nm to 700 nm under an excitation of 147 nm radiation from a deuterium lamp. The X-ray diffraction data were obtained over the scattering angle range $10^{\circ} \le 2q \le$ 130 ° at a 2q? step of 0.02 using CuK_a radiation with a graphite monochromator at room temperature (Rigaku Dmax2200V). The structural refinement was made with the general structure analysis system (GSAS) program [6]. A pseudo-Voigt function was chosen as a profile function among the profile functions in GSAS.

3. Results and discussion

Figure 1 shows X-ray diffraction patterns of polymorph BAS:Eu²⁺ for firing at 1300 and 1400 , respectively. Lin and Forster, during an investigation of BAS polymorphism, concluded that there are four polymorphs of BAS (viz. paracelsian form, orthorhombic form, hexagonal form, and monoclinic form) [7]. Among existed polymorphs of BAS, we

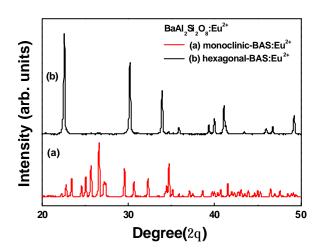


Figure 1. XRD spectra BaAl₂Si₂O₈:Eu²⁺ :(a) monoclinic -BAS:Eu²⁺, (b)hexagonal-BAS:Eu²⁺.

could make a hexagonal, monoclinic-BAS of single phase by changing of firing temperatures as shown Fig.1.

The emission spectra of polymorph BAS:Eu²⁺ under VUV excitation source are shown in Fig.2. In the PL spectra, the emission peak of BAS:Eu²⁺ were centered at 373, 434 nm, respectively. Their emission bands correspond to the transition from the 4f⁶5d excited state to the 4f⁷ ground state of a Eu²⁺ ion. However, due to difference of its crystal structure such as hexagonal, monoclinic, the 5d electrons are affected by the crystal field significantly depending upon their crystal structure. The emission wavelength Eu²⁺-activated phosphor was determined relationship between ${}^6P_{7/2}$ as well as 5d and lowest ${}^8S_{7/2}$ level [8]. For hexagonal-BAS:Eu²⁺, the emission peak at

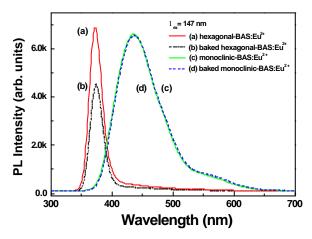
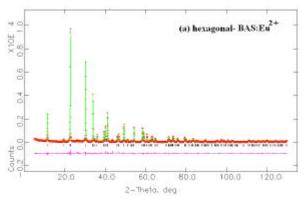


Figure 2. PL spectra of BaA½Si₂O₈:Eu²⁺ before and after baking process.



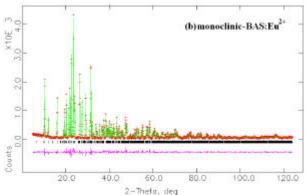


Figure 3. The Rietveld refinement patterns for polymorph BAS:Eu X-ray powder diffraction data: (a) hexagonal-BAS:Eu²⁺, (b) monoclinic-BAS:Eu²⁺. Dot marks represent the observed intensities, and the solid line is calculated ones. A difference (obs. - cal.) plot is shown beneath. Tick marks above the difference data indicate the reflection position.

374 nm can ascribed to transition of ${}^6P_{7/2} - {}^8S_{7/2}$ of Eu²⁺ ions. On the other hand, for monoclinic-BAS:Eu²⁺, due to strong crystal field around Eu²⁺ ions, the lowest 5d level would become lower than ${}^6P_{7/2}$ level. Therefore, its emission peak was observed 434 nm.

The Rietveld refinement against XRD data was carried out to quantitatively confirm the sensitiveness of Eu²⁺ ions to outer oxidation atmosphere. Figure 3 shows Rietveld refinement results of polymorph BAS:Eu²⁺, respectively. The structural parameters for polymorph BAS:Eu²⁺ were successfully determined by the Rietveld refinement using X-ray powder diffraction data. For hexagonal BAS: Eu²⁺, the final weighted R-factor, $R_{\rm wp}$, was 11.77 % and the goodness-of-fit indicator, S (= $R_{\rm wp}$ / $R_{\rm e}$), was 1515. For monoclinic-BAS:Eu²⁺, $R_{\rm wp}$ was 11.36 % and Swas 1355. The initial structural model which have approximations for the actual structure for polymorph BAS:Eu²⁺ was constructed with crystallographic data based on hexagonal, monoclinic space group P3, I/2c. The initial structural refinement cycles included the zero-point shift, the lattice parameters, the scale factor and background parameters as variables. Following satisfactory matching of peak positions, the atomic positions, the thermal parameters and the peak profile parameters including the peak asymmetry were refined. Si (NIST 640c) powder was used as an external standard to correct the zero-point shift for the measured diffraction data.

Monoclinic -BAS:Eu²⁺ has a space group I/2c, and Eu²⁺ ions sharing the same site as Ba²⁺ ions surrounded tightly with each set of tetrahedral SiO₄ and AlO₄ units the one above and below. On the other hand, Eu²⁺ ions substituting for Ba sites in hexagonal BAS:Eu²⁺ with a space group $P\overline{3}$, occupy the sites sandwiched by the double layers. The site corresponds to the position of open layer structure. Considering

sandwiched by the double layers. The site corresponds to the position of open layer structure. Considering their crystal structures, Eu²⁺ ions in hexagonal BAS:Eu²⁺ may be more susceptible to outer oxidation atmosphere than that of monoclinc-BAS:Eu²⁺ because the substitutional sites of Eu²⁺ ions in hexagonal BAS:Eu²⁺ are placed in an open layer.

From Rietveld refinement results, the average interatomic length between Eu^{2^+} and oxygen $(d_{Eu\cdot O})$ in monoclinic-BAS: Eu^{2^+} was 2.98805(4) Å while $d_{Eu\cdot O}$ of hexagonal-BAS: Eu^{2^+} was 3.31805(4) Å The difference of $d_{Eu\cdot O}$ in the two crystal structures supports that Eu^{2^+} ions substituting for the Ba^{2^+} ions in hexagonal-BAS: Eu^{2^+} may be more sensitive than them of the monoclinic-BAS: Eu^{2^+} to the external environmental conditions such as temperature and oxidation atmosphere because $d_{Eu\cdot O}$ of hexagonal-BAS: Eu^{2^+} is longer than that of monoclinc-BAS: Eu^{2^+} , and also Eu^{2^+} ions of hexagonal-BAS: Eu^{2^+} occupy the position.

4. Conclusion

In conclusion, the difference of thermal stability of monoclinic- and hexagonal-BAS:Eu²⁺ can be ascribed to both crystal structures and the average inter-atomic

length between Eu^{2^+} ion and oxygen. This study suggests that the host lattice having a non opened-structure and the substitutional site to make $d_{\mathrm{Eu-O}}$ to be short in the host lattice should be considered as an important criterion of selection of host lattice for thermal stability during the baking process.

5. Acknowledgements

This study was supported by Korea Science and Engineering Foundation (KOSEF) and Ministry of Science & Technology (MOST), Korean government, through its National Nuclear Technology Program.

6. References

- [1] S. Oshio, T. Matsuoka, S. Tanaka and H. Kobayashi, J. Electrochem. Soc., 145, 11, p. 3903 (1998).
- [2] T. H. Kwon, M. S. Kang, J.P. Kim, G. J. Kim, Proc. Int. Display Workshop' 01, p. 1051 (2001)
- [3] L. Tian, B. Y. Yu, C. H. Pyun, H. L. Park and S. I. Mho, Solid State Commun., 129, p. 43 (2004).
- [4] T. Kunimoto, R. Yoshimatsu, K. Ohmi, S. Tanaka and H. Kobayashi, IEICE TRANS. EIECTRON. E85-C, 11 (2002).
- [5] W. B. Im, J. H. Kang, D. C. Lee, S. Lee, D. Y. Jeon, Y. C. Kang and K. Y. Jung, Solid State Communication. 133, 197 (2005).
- [6] A.C. Larson and R.B. Von Dreele: General Structure Analysis System (GSAS). Los Alamos National Laboratory Report LAUR. 86, 748 (1994).
- [7] C. Lin and W. R. Foster, Am. Mineralogist, 53, p. 134 (1968).
- [8] S. Shinoya and W. M. Yen, eds., Phosphor Handbook. (CRC press, 1998).